

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/796,202	FUJII	
Examiner	Art Unit	
Erica E. Cadugan	3722	

	SEARCHED					
Class	Subclass	Date	Examiner			
29	33Q, 33S, 33F, 564	11/22/2005	EEC			
140	139, 140					
	147					
72	43-44					
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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	SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR			
PALM Inventor Search	11/22/2005	EEC			
EAST Text					
Consulted Lowell Larson, class 140, class 72					